TOSHIBA Field Effect Transistor Silicon N Channel MOS Type ( $\pi$ -MOS VI)

## 2SK3127

# Chopper Regulator, DC-DC Converter and Motor Drive Applications

- Low drain-source ON resistance:  $RDS(ON) = 9.5 \Omega \text{ (typ.)}$
- High forward transfer admittance:  $|Y_{fs}| = 38 S$  (typ.)
- Low leakage current:  $IDSS = 100 \mu A \text{ (max) (V}_{DS} = 30 \text{ V)}$
- Enhancement-mode:  $V_{th} = 1.5 \text{ to } 3.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA)}$

#### Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	30	V	
Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ )		$V_{DGR}$	30	٧	
Gate-source voltage		$V_{GSS}$	±20	٧	
Drain current	DC (Note 1)	I <sub>D</sub>	45	Α	
	Pulse (Note 1)	$I_{DP}$	135		
Drain power dissipation	(Tc = 25°C)	$P_{D}$	65	W	
Single pulse avalanche energy (Note 2)		E <sub>AS</sub>	524	mJ	
Avalanche current		I <sub>AR</sub>	45	Α	
Repetitive avalanche e	nergy (Note 3)	E <sub>AR</sub>	6	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature range		T <sub>stg</sub>	-55 to 150	°C	

- Note 1: Please use devices on condition that the channel temperature is below 150°C.
- Note 2:  $V_{DD}=25$  V,  $T_{ch}=25^{\circ}C$  (initial), L=186  $\mu H,~R_{G}=25$   $\Omega,~I_{AR}=45$  A
- Note 3: Repetitive rating: pulse width limited by maximum junction temperature.
- Note 4: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

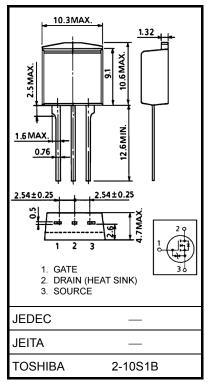
This transistor is an electrostatic sensitive device.

Please handle with caution.

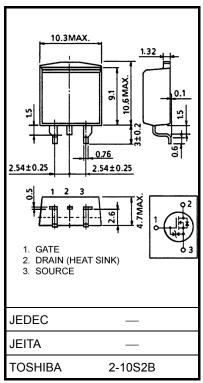
#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	1.92	°C/W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	83.3	°C/W

Unit: mm



Weight: 1.5 g (typ.)



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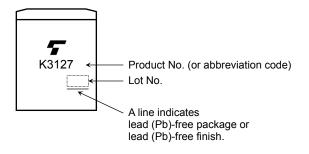
### **Electrical Characteristics (Ta = 25°C)**

Character	ristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I <sub>GSS</sub>	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μА
Drain cut-off current		I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V		_	100	μА
Drain-source breakdo	wn voltage	V (BR) DSS	$I_D = 10$ mA, $V_{GS} = 0$ V	30	_	_	V
Gate threshold voltag	е	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.5	_	3.0	V
Drain-source ON resi	stance	R <sub>DS (ON)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 25 A	_	9.5	12	mΩ
Forward transfer adm	ittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 25 A	19	40	_	S
Input capacitance		C <sub>iss</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	2300	_	pF
Reverse transfer capacitance		C <sub>rss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	380	_	pF
Output capacitance		Coss	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	1100	_	pF
Switching time	Rise time	t <sub>r</sub>	10 V	_	12	_	
	Turn-on time	t <sub>on</sub>		_	25	_	ns
	Fall time	t <sub>f</sub>		_	75	_	115
	Turn-off time	t <sub>off</sub>	V <sub>DD</sub> ≃ 15 V Duty ≤ 1%, t <sub>W</sub> = 10 μs	_	200	_	
Total gate charge (gate-source plus gate	otal gate charge gate-source plus gate-drain) Qg		$V_{DD} \simeq 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 45 \text{ A}$	_	66	_	nC
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \simeq 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 45 \text{ A}$	_	45	_	nC
Gate-drain ("miller") charge		Q <sub>gd</sub>	$V_{DD} \simeq 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 45 \text{ A}$	_	21	_	nC

## **Source-Drain Ratings and Characteristics (Ta = 25°C)**

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	_	_	45	Α
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	_	_	_	135	Α
Forward voltage (diode)	V <sub>DSF</sub>	$I_{DR} = 45 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-1.7	V
Reverse recovery time	t <sub>rr</sub>	I <sub>DR</sub> = 45 A, V <sub>GS</sub> = 0 V, dI <sub>DR</sub> /dt = 50 A/μs	_	150	_	ns
Reverse recovery charge	Q <sub>rr</sub>	$I_{DR} = 45 \text{ A}, V_{GS} = 0 \text{ V},$ $dI_{DR}/dt = 50 \text{ A}/\mu\text{s}$		270	ı	nC

## Marking



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